

AN79M00/AN79M00F Series

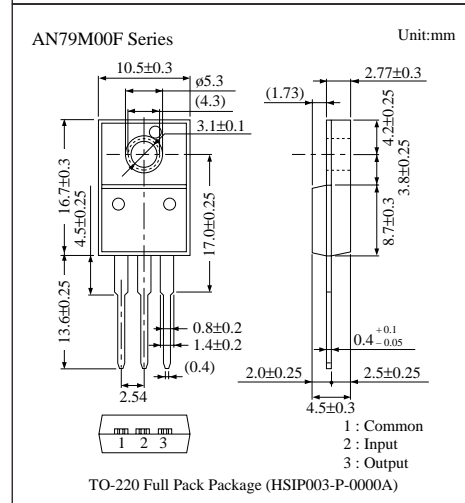
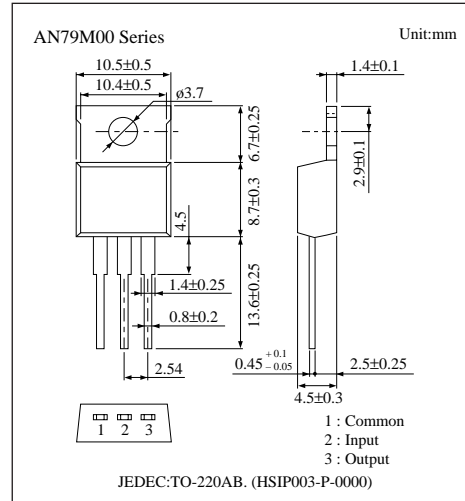
3-pin Negative Output Voltage Regulators (500mA Type)

■ Overview

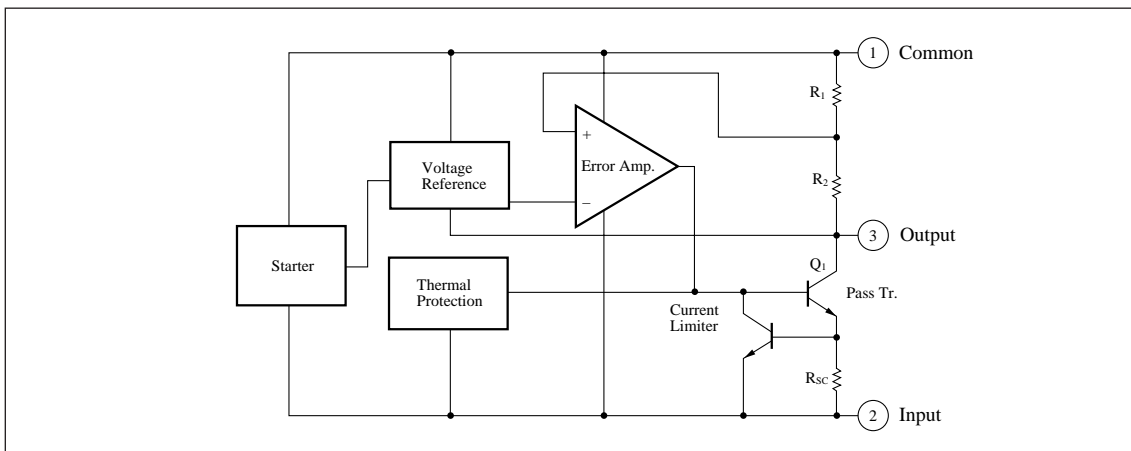
The AN79M00 and the AN79M00F series are 3-pin fixed negative output voltage regulators. Stabilized fixed output voltage is obtained from unstable DC input voltage without using any external components. 12 types of output voltage are available ; $-5V$, $-5.2V$, $-6V$, $-7V$, $-8V$, $-9V$, $-10V$, $-12V$, $-15V$, $-18V$, $-20V$ and $-24V$. They can be used widely in power circuits with current capacitance up to 500mA.

■ Features

- No external components
- Output voltage : $-5V$, $-5.2V$, $-6V$, $-7V$, $-8V$, $-9V$, $-10V$, $-12V$, $-15V$, $-18V$, $-20V$, $-24V$
- Short-circuit current limiting built-in
- Thermal overload protection built-in
- Output transistor safe area compensation



■ Block Diagram



■ Absolute Maximum Ratings (Ta=25°C)

Parameter	Symbol	Rating	Unit
Input voltage	V _I	-35 * ¹	V
		-40 * ²	V
Power dissipation	P _D	15 * ³	W
		10.25 * ³	
Operating ambient temperature	T _{opr}	-20 to +80	°C
Storage temperature	T _{stg}	-55 to +150	°C

*1 AN79M05/F, AN79M52/F, AN79M06/F, AN79M07/F, AN79M08/F, AN79M09/F, AN79M10/F, AN79M12/F, AN79M15/F, AN79M18/F

*2 AN79M20/F, AN79M24/F

*3 Follow the derating curve. When T_j exceeds 150°C, the internal circuit cuts off the output.

■ Electrical Characteristics (Ta=25°C)

• AN79M05/AN79M05F (-5V Type)

Parameter	Symbol	Condition	min	typ	max	Unit
Output voltage	V _O	T _j =25°C	-4.8	-5	-5.2	V
Output voltage tolerance	V _O	V _I =-7 to -25V, I _O =5 to 350mA, P _D ≤*	-4.75	—	-5.25	V
Line regulation	REG _{IN}	V _I =-7 to -25V, T _j =25°C	—	3	50	mV
		V _I =-8 to -18V, T _j =25°C	—	1	30	mV
Load regulation	REG _L	I _O =5 to 500mA, T _j =25°C	—	20	100	mV
		I _O =5 to 350mA, T _j =25°C	—	10	50	mV
Bias current	I _{Bias}	T _j =25°C	—	2	4	mA
Input bias current fluctuation	ΔI _{bias (IN)}	V _I =-8 to -25V, T _j =25°C	—	—	0.8	mA
Load bias current fluctuation	ΔI _{bias (L)}	I _O =5 to 350mA, T _j =25°C	—	—	0.4	mA
Output noise voltage	V _{no}	f=10Hz to 100kHz, Ta=25°C	—	125	—	μV
Ripple rejection ratio	RR	V _I =-8 to -18V, I _O =100mA, f=120Hz, Ta=25°C	60	—	—	dB
Minimum input/output voltage difference	V _{DIF (min.)}	T _j =25°C	—	1.1	—	V
Output short circuit current	I _{O (Short)}	V _I =-35V, T _j =25°C	—	50	—	mA
Peak output current	I _{O (peak)}	T _j =25°C	—	1000	—	mA
Output voltage temperature coefficient	ΔV _O /Ta	I _O =5mA, T _i =0 to 125°C	—	-0.4	—	mV/°C

Note 1) The specified condition T_j=25°C means that the test should be carried out with the test time so short (within 10ms) that the drift in characteristic value due to the rise in chip junction temperature can be ignored.

Note 2) When not specified, V_I=-10V, I_O=350mA, C_I=2μF, C_O=1μF and T_j=0 to 125°C

* AN79M05 : 15W, AN79M05F : 10.25W

■ Electrical Characteristics (Ta=25°C)

• AN79M52/AN79M52F (-5.2V Type)

Parameter	Symbol	Condition	min	typ	max	Unit
Output voltage	V _O	T _j =25°C	-5.0	-5.2	-5.4	V
Output voltage tolerance	V _O	V _I =-7 to -25V, I _O =5 to 350mA, P _D ≤*	-4.94	—	-5.46	V
Line regulation	REG _{IN}	V _I =-7 to -25V, T _j =25°C	—	—	50	mV
		V _I =-8 to -18V, T _j =25°C	—	—	30	mV
Load regulation	REG _L	I _O =5 to 500mA, T _j =25°C	—	—	100	mV
		I _O =5 to 350mA, T _j =25°C	—	—	50	mV
Bias current	I _{Bias}	T _j =25°C	—	2	4	mA
Input bias current fluctuation	ΔI _{bias (IN)}	V _I =-8 to -25V, T _j =25°C	—	—	0.8	mA
Load bias current fluctuation	ΔI _{bias (L)}	I _O =5 to 350mA, T _j =25°C	—	—	0.4	mA
Output noise voltage	V _{no}	f=10Hz to 100kHz, Ta=25°C	—	130	—	μV
Ripple rejection ratio	RR	V _I =-8 to -18V, f=120Hz, I _O =100mA	60	—	—	dB
Minimum input/output voltage difference	V _{DIF (min.)}	T _j =25°C	—	1.1	—	V
Output short circuit current	I _{O (Short)}	V _I =-35V, T _j =25°C	—	50	—	mA
Peak output current	I _{O (peak)}	T _j =25°C	—	1000	—	mA
Output voltage temperature coefficient	ΔV _O /Ta	I _O =5mA, T _j =0 to 125°C	—	-0.4	—	mV/°C

Note 1) The specified condition T_j=25°C means that the test should be carried out with the test time so short (within 10ms) that the drift in characteristic value due to the rise in chip junction temperature can be ignored.

Note 2) When not specified, V_I=-10V, I_O=350mA, C_I=2μF, C_O=1μF and T_j=0 to 125°C

* AN79M52 : 15W, AN79M52F : 10.25W

• AN79M06/AN79M06F (-6V Type)

Parameter	Symbol	Condition	min	typ	max	Unit
Output voltage	V _O	T _j =25°C	-5.75	-6	-6.25	V
Output voltage tolerance	V _O	V _I =-8 to -25V, I _O =3 to 350mA, P _D ≤*	-5.7	—	-6.3	V
Line regulation	REG _{IN}	V _I =-8 to -25V, T _j =25°C	—	5	60	mV
		V _I =-9 to -19V, T _j =25°C	—	1.5	40	mV
Load regulation	REG _L	I _O =5 to 500mA, T _j =25°C	—	20	120	mV
		I _O =5 to 350mA, T _j =25°C	—	10	60	mV
Bias current	I _{Bias}	T _j =25°C	—	2	4	mA
Input bias current fluctuation	ΔI _{bias (IN)}	V _I =-9 to -25V, T _j =25°C	—	—	0.8	mA
Load bias current fluctuation	ΔI _{bias (L)}	I _O =5 to 350mA, T _j =25°C	—	—	0.4	mA
Output noise voltage	V _{no}	f=10Hz to 100kHz, Ta=25°C	—	150	—	μV
Ripple rejection ratio	RR	V _I =-9 to -19V, I _O =100mA, f=120Hz, Ta=25°C	60	—	—	dB
Minimum input/output voltage difference	V _{DIF (min.)}	T _j =25°C	—	1.1	—	V
Output short circuit current	I _{O (Short)}	V _I =-35V, T _j =25°C	—	50	—	mA
Peak output current	I _{O (peak)}	T _j =25°C	—	1000	—	mA
Output voltage temperature coefficient	DV _O /Ta	I _O =5mA, T _j =0 to 125°C	—	-0.4	—	mV/°C

Note 1) The specified condition T_j=25°C means that the test should be carried out with the test time so short (within 10ms) that the drift in characteristic value due to the rise in chip junction temperature can be ignored.

Note 2) When not specified, V_I=-11V, I_O=350mA, C_I=2μF, C_O=1μF and T_j=0 to 125°C

* AN79M06 : 15W, AN79M06F : 10.25W

■ Electrical Characteristics (Ta=25°C)

• AN79M07/AN79M07F (-7V Type)

Parameter	Symbol	Condition	min	typ	max	Unit
Output voltage	V _O	T _j =25°C	-6.7	-7	-7.3	V
Output voltage tolerance	V _O	V _I =-9 to -25V, I _O =5 to 350mA, P _D ≤*	-6.65	—	-7.35	V
Line regulation	REG _{IN}	V _I =-9 to -25V, T _j =25°C	—	6	70	mV
		V _I =-10 to -20V, T _j =25°C	—	2	35	mV
Load regulation	REG _L	I _O =5 to 500mA, T _j =25°C	—	20	140	mV
		I _O =5 to 350mA, T _j =25°C	—	10	70	mV
Bias current	I _{Bias}	T _j =25°C	—	2	4	mA
Input bias current fluctuation	ΔI _{bias (IN)}	V _I =-10 to -25V, T _j =25°C	—	—	0.8	mA
Load bias current fluctuation	ΔI _{bias (L)}	I _O =5 to 350mA, T _j =25°C	—	—	0.4	mA
Output noise voltage	V _{no}	f=10Hz to 100kHz, Ta=25°C	—	175	—	μV
Ripple rejection ratio	RR	V _I =-10 to -20V, I _O =100mA, f=120Hz, Ta=25°C	59	—	—	dB
Minimum input/output voltage difference	V _{DIF (min.)}	T _j =25°C	—	1.1	—	V
Output short circuit current	I _{O (Short)}	V _I =-35V, T _j =25°C	—	50	—	mA
Peak output current	I _{O (peak)}	T _j =25°C	—	1000	—	mA
Output voltage temperature coefficient	ΔV _O /Ta	I _O =5mA, T _j =0 to 125°C	—	-0.5	—	mV/°C

Note 1) The specified condition T_j=25°C means that the test should be carried out with the test time so short (within 10ms) that the drift in characteristic value due to the rise in chip junction temperature can be ignored.

Note 2) When not specified, V_I=-12V, I_O=350mA, C₁=2μF, C_O=1μF and T_j=0 to 125°C

* AN79M07 : 15W, AN79M07F : 10.25W

• AN79M08/AN79M08F (-8V Type)

Parameter	Symbol	Condition	min	typ	max	Unit
Output voltage	V _O	T _j =25°C	-7.7	-8	-8.3	V
Output voltage tolerance	V _O	V _I =-10.5 to -25V, I _O =5 to 350mA, P _D ≤*	-7.6	—	-8.4	V
Line regulation	REG _{IN}	V _I =-10.5 to -25V, T _j =25°C	—	6	80	mV
		V _I =-11 to -21V, T _j =25°C	—	2	40	mV
Load regulation	REG _L	I _O =5 to 500mA, T _j =25°C	—	25	160	mV
		I _O =5 to 350mA, T _j =25°C	—	10	80	mV
Bias current	I _{Bias}	T _j =25°C	—	2	4	mA
Input bias current fluctuation	ΔI _{bias (IN)}	V _I =-10.5 to -25V, T _j =25°C	—	—	0.8	mA
Load bias current fluctuation	ΔI _{bias (L)}	I _O =5 to 350mA, T _j =25°C	—	—	0.4	mA
Output noise voltage	V _{no}	f=10Hz to 100kHz, Ta=25°C	—	200	—	μV
Ripple rejection ratio	RR	V _I =-11.5 to -21.5V, I _O =100mA, f=120Hz, Ta=25°C	59	—	—	dB
Minimum input/output voltage difference	V _{DIF (min.)}	T _j =25°C	—	1.1	—	V
Output short circuit current	I _{O (Short)}	V _I =-35V, T _j =25°C	—	50	—	mA
Peak output current	I _{O (peak)}	T _j =25°C	—	1000	—	mA
Output voltage temperature coefficient	ΔV _O /Ta	I _O =5mA, T _j =0 to 125°C	—	-0.6	—	mV/°C

Note 1) The specified condition T_j=25°C means that the test should be carried out with the test time so short (within 10ms) that the drift in characteristic value due to the rise in chip junction temperature can be ignored.

Note 2) When not specified, V_I=-14V, I_O=350mA, C₁=2μF, C_O=1μF and T_j=0 to 125°C

* AN79M08 : 15W, AN79M08F : 10.25W

■ Electrical Characteristics (Ta=25°C)

• AN79M09/AN79M09F (-9V Type)

Parameter	Symbol	Condition	min	typ	max	Unit
Output voltage	V _O	T _j =25°C	-8.65	-9	-9.35	V
Output voltage tolerance	V _O	V _I =-11.5 to -26V, I _O =5 to 350mA, P _D ≤*	-8.55	—	-9.45	V
Line regulation	REG _{IN}	V _I =-11.5 to -26V, T _j =25°C	—	7	80	mV
		V _I =-12 to -22V, T _j =25°C	—	2	50	mV
Load regulation	REG _L	I _O =5 to 500mA, T _j =25°C	—	25	180	mV
		I _O =5 to 350mA, T _j =25°C	—	10	90	mV
Bias current	I _{Bias}	T _j =25°C	—	2	4	mA
Input bias current fluctuation	ΔI _{bias (IN)}	V _I =-11.5 to -26V, T _j =25°C	—	—	0.8	mA
Load bias current fluctuation	ΔI _{bias (L)}	I _O =5 to 350mA, T _j =25°C	—	—	0.4	mA
Output noise voltage	V _{no}	f=10Hz to 100kHz, Ta=25°C	—	225	—	μV
Ripple rejection ratio	RR	V _I =-12 to -22V, I _O =100mA, f=120Hz, Ta=25°C	58	—	—	dB
Minimum input/output voltage difference	V _{DIF (min.)}	T _j =25°C	—	1.1	—	V
Output short circuit current	I _{O (Short)}	V _I =-35V, T _j =25°C	—	50	—	mA
Peak output current	I _{O (peak)}	T _j =25°C	—	1000	—	mA
Output voltage temperature coefficient	ΔV _O /Ta	I _O =5mA, T _j =0 to 125°C	—	-0.6	—	mV/°C

Note 1) The specified condition T_j=25°C means that the test should be carried out with the test time so short (within 10ms) that the drift in characteristic value due to the rise in chip junction temperature can be ignored.

Note 2) When not specified, V_I=-15V, I_O=350mA, C_I=2μF, C_O=1μF and T_j=0 to 125°C

* AN79M09 : 15W, AN79M09F : 10.25W

• AN79M10/AN79M10F (-10V Type)

Parameter	Symbol	Condition	min	typ	max	Unit
Output voltage	V _O	T _j =25°C	-9.6	-10	-10.4	V
Output voltage tolerance	V _O	V _I =-12.5 to -27V, I _O =5 to 350mA, P _D ≤*	-9.5	—	-10.5	V
Line regulation	REG _{IN}	V _I =-12.5 to -27V, T _j =25°C	—	7	80	mV
		V _I =-13 to -23V, T _j =25°C	—	2	50	mV
Load regulation	REG _L	I _O =5 to 500mA, T _j =25°C	—	25	200	mV
		I _O =5 to 350mA, T _j =25°C	—	10	100	mV
Bias current	I _{Bias}	T _j =25°C	—	2	4	mA
Input bias current fluctuation	ΔI _{bias (IN)}	V _I =-12.5 to -27V, T _j =25°C	—	—	0.8	mA
Load bias current fluctuation	ΔI _{bias (L)}	I _O =5 to 350mA, T _j =25°C	—	—	0.4	mA
Output noise voltage	V _{no}	f=10Hz to 100kHz, Ta=25°C	—	250	—	μV
Ripple rejection ratio	RR	V _I =-13 to -23V, I _O =100mA, f=120Hz, Ta=25°C	58	—	—	dB
Minimum input/output voltage difference	V _{DIF (min.)}	T _j =25°C	—	1.1	—	V
Output short circuit current	I _{O (Short)}	V _I =-35V, T _j =25°C	—	50	—	mA
Peak output current	I _{O (peak)}	T _j =25°C	—	1000	—	mA
Output voltage temperature coefficient	ΔV _O /Ta	I _O =5mA, T _j =0 to 125°C	—	-0.7	—	mV/°C

Note 1) The specified condition T_j=25°C means that the test should be carried out with the test time so short (within 10ms) that the drift in characteristic value due to the rise in chip junction temperature can be ignored.

Note 2) When not specified, V_I=-16V, I_O=350mA, C_I=2μF, C_O=1μF and T_j=0 to 125°C

* AN79M10 : 15W, AN79M10F : 10.25W

■ Electrical Characteristics (Ta=25°C)

• AN79M12/AN79M12F (-12V Type)

Parameter	Symbol	Condition	min	typ	max	Unit
Output voltage	V _O	T _j =25°C	-11.5	-12	-12.5	V
Output voltage tolerance	V _O	V _I =-14.5 to -30V, I _O =5 to 350mA, P _D ≤*	-11.4	—	-12.6	V
Line regulation	REG _{IN}	V _I =-14.5 to -30V, T _j =25°C	—	8	80	mV
		V _I =-15 to -25V, T _j =25°C	—	2	50	mV
Load regulation	REG _L	I _O =5 to 500mA, T _j =25°C	—	25	240	mV
		I _O =5 to 350mA, T _j =25°C	—	10	120	mV
Bias current	I _{Bias}	T _j =25°C	—	2	4	mA
Input bias current fluctuation	ΔI _{bias (IN)}	V _I =-14.5 to -30V, T _j =25°C	—	—	0.8	mA
Load bias current fluctuation	ΔI _{bias (L)}	I _O =5 to 350mA, T _j =25°C	—	—	0.4	mA
Output noise voltage	V _{no}	f=10Hz to 100kHz, Ta=25°C	—	300	—	μV
Ripple rejection ratio	RR	V _I =-15 to -25V, I _O =100mA, f=120Hz, Ta=25°C	57	—	—	dB
Minimum input/output voltage difference	V _{DIF (min.)}	T _j =25°C	—	1.1	—	V
Output short circuit current	I _{O (Short)}	V _I =-35V, T _j =25°C	—	50	—	mA
Peak output current	I _{O (peak)}	T _j =25°C	—	1000	—	mA
Output voltage temperature coefficient	ΔV _O /Ta	I _O =5mA, T _j =0 to 125°C	—	-0.8	—	mV/°C

Note 1) The specified condition T_j=25°C means that the test should be carried out with the test time so short (within 10ms) that the drift in characteristic value due to the rise in chip junction temperature can be ignored.

Note 2) When not specified, V_I=-19V, I_O=350mA, C₁=2μF, C_O=1μF and T_j=0 to 125°C

* AN79M12 : 15W, AN79M12F : 10.25W

• AN79M15/AN79M15F (-15V Type)

Parameter	Symbol	Condition	min	typ	max	Unit
Output voltage	V _O	T _j =25°C	-14.4	-15	-15.6	V
Output voltage tolerance	V _O	V _I =-17.5 to -30V, I _O =5 to 350mA, P _D ≤*	-14.25	—	-15.75	V
Line regulation	REG _{IN}	V _I =-17.5 to -30V, T _j =25°C	—	10	80	mV
		V _I =-18 to -28V, T _j =25°C	—	3	50	mV
Load regulation	REG _L	I _O =5 to 500mA, T _j =25°C	—	25	240	mV
		I _O =5 to 350mA, T _j =25°C	—	10	120	mV
Bias current	I _{Bias}	T _j =25°C	—	2	4	mA
Input bias current fluctuation	ΔI _{bias (IN)}	V _I =-17.5 to -30V, T _j =25°C	—	—	0.8	mA
Load bias current fluctuation	ΔI _{bias (L)}	I _O =5 to 350mA, T _j =25°C	—	—	0.4	mA
Output noise voltage	V _{no}	f=10Hz to 100kHz, Ta=25°C	—	375	—	μV
Ripple rejection ratio	RR	V _I =-18 to -28V, I _O =100mA, f=120Hz, Ta=25°C	56	—	—	dB
Minimum input/output voltage difference	V _{DIF (min.)}	T _j =25°C	—	1.1	—	V
Output short circuit current	I _{O (Short)}	V _I =-35V, T _j =25°C	—	50	—	mA
Peak output current	I _{O (peak)}	T _j =25°C	—	1000	—	mA
Output voltage temperature coefficient	ΔV _O /Ta	I _O =5mA, T _j =0 to 125°C	—	-0.9	—	mV/°C

Note 1) The specified condition T_j=25°C means that the test should be carried out with the test time so short (within 10ms) that the drift in characteristic value due to the rise in chip junction temperature can be ignored.

Note 2) When not specified, V_I=-23V, I_O=350mA, C₁=2μF, C_O=1μF and T_j=0 to 125°C

* AN79M15 : 15W, AN79M15F : 10.25W

■ Electrical Characteristics (Ta=25°C)

• AN79M18/AN79M18F (-18V Type)

Parameter	Symbol	Condition	min	typ	max	Unit
Output voltage	V _O	T _j =25°C	-17.3	-18	-18.7	V
Output voltage tolerance	V _O	V _I =-21 to -33V, I _O =5 to 350mA, P _D ≤*	-17.1	—	-18.9	V
Line regulation	REG _{IN}	V _I =-21 to -33V, T _j =25°C	—	10	80	mV
		V _I =-22 to -32V, T _j =25°C	—	5	50	mV
Load regulation	REG _L	I _O =5 to 500mA, T _j =25°C	—	30	300	mV
		I _O =5 to 350mA, T _j =25°C	—	10	150	mV
Bias current	I _{Bias}	T _j =25°C	—	2	4	mA
Input bias current fluctuation	ΔI _{bias (IN)}	V _I =-21 to -33V, T _j =25°C	—	—	0.8	mA
Load bias current fluctuation	ΔI _{bias (L)}	I _O =5 to 350mA, T _j =25°C	—	—	0.4	mA
Output noise voltage	V _{no}	f=10Hz to 100kHz, Ta=25°C	—	450	—	μV
Ripple rejection ratio	RR	V _I =-22 to -32V, I _O =100mA, f=120Hz, Ta=25°C	55	—	—	dB
Minimum input/output voltage difference	V _{DIF (min.)}	T _j =25°C	—	1.1	—	V
Output short circuit current	I _{O (Short)}	V _I =-35V, T _j =25°C	—	50	—	mA
Peak output current	I _{O (peak)}	T _j =25°C	—	1000	—	mA
Output voltage temperature coefficient	ΔV _O /Ta	I _O =5mA, T _j =0 to 125°C	—	-1	—	mV/°C

Note 1) The specified condition T_j=25°C means that the test should be carried out with the test time so short (within 10ms) that the drift in characteristic value due to the rise in chip junction temperature can be ignored.

Note 2) When not specified, V_I=-27V, I_O=350mA, C_I=2μF, C_O=1μF and T_j=0 to 125°C

* AN79M18 : 15W, AN79M18F : 10.25W

• AN79M20/AN79M20F (-20V Type)

Parameter	Symbol	Condition	min	typ	max	Unit
Output voltage	V _O	T _j =25°C	-19.2	-20	-20.8	V
Output voltage tolerance	V _O	V _I =-23 to -35V, I _O =5 to 350mA, P _D ≤*	-19	—	-21	V
Line regulation	REG _{IN}	V _I =-23 to -35V, T _j =25°C	—	10	80	mV
		V _I =-24 to -34V, T _j =25°C	—	5	50	mV
Load regulation	REG _L	I _O =5 to 500mA, T _j =25°C	—	30	300	mV
		I _O =5 to 350mA, T _j =25°C	—	10	150	mV
Bias current	I _{Bias}	T _j =25°C	—	2	4	mA
Input bias current fluctuation	ΔI _{bias (IN)}	V _I =-23 to -35V, T _j =25°C	—	—	0.8	mA
Load bias current fluctuation	ΔI _{bias (L)}	I _O =5 to 350mA, T _j =25°C	—	—	0.4	mA
Output noise voltage	V _{no}	f=10Hz to 100kHz, Ta=25°C	—	500	—	μV
Ripple rejection ratio	RR	V _I =-24 to -34V, I _O =100mA, f=120Hz, Ta=25°C	54	—	—	dB
Minimum input/output voltage difference	V _{DIF (min.)}	T _j =25°C	—	1.1	—	V
Output short circuit current	I _{O (Short)}	V _I =-35V, T _j =25°C	—	50	—	mA
Peak output current	I _{O (peak)}	T _j =25°C	—	1000	—	mA
Output voltage temperature coefficient	ΔV _O /Ta	I _O =5mA, T _j =0 to 125°C	—	-1	—	mV/°C

Note 1) The specified condition T_j=25°C means that the test should be carried out with the test time so short (within 10ms) that the drift in characteristic value due to the rise in chip junction temperature can be ignored.

Note 2) When not specified, V_I=-29V, I_O=350mA, C_I=2μF, C_O=1μF and T_j=0 to 125°C

* AN79M20 : 15W, AN79M20F : 10.25W

■ Electrical Characteristics (Ta=25°C)

• AN79M24/AN79M24F (-24V Type)

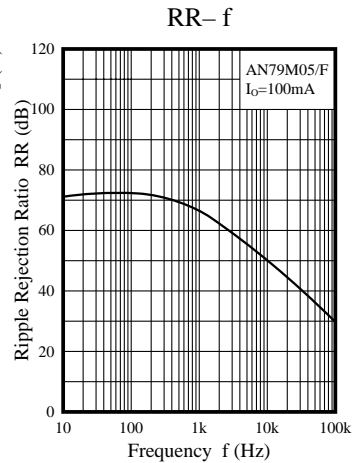
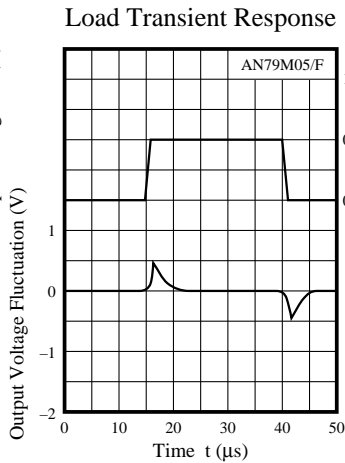
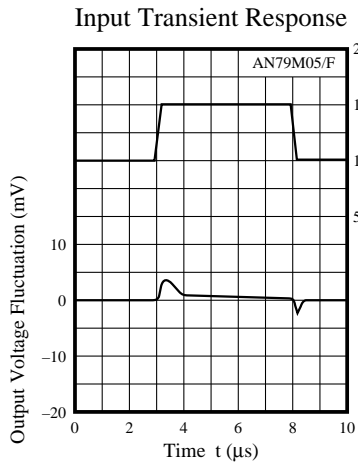
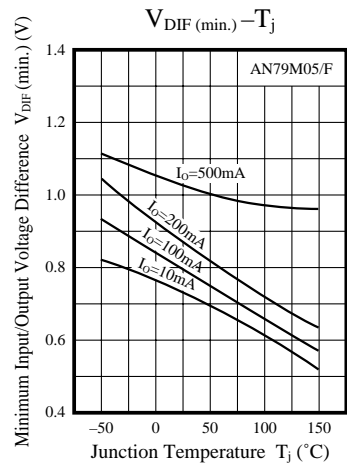
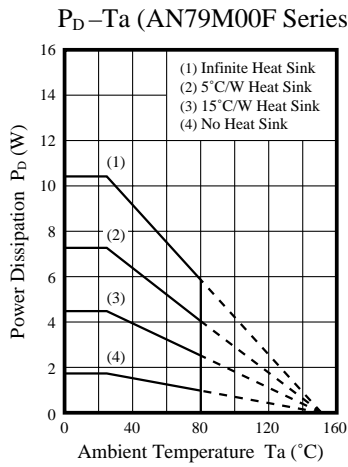
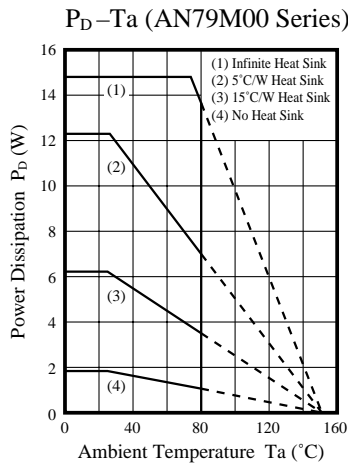
Parameter	Symbol	Condition	min	typ	max	Unit
Output voltage	V_O	$T_j=25^\circ\text{C}$	-23	-24	-25	V
Output voltage tolerance	V_O	$V_I=-27$ to -38V , $I_O=5$ to 350mA , $P_D \leq *$	-22.8	—	-25.2	V
Line regulation	REG_{IN}	$V_I=-27$ to -38V , $T_j=25^\circ\text{C}$	—	10	80	mV
		$V_I=-27$ to -37V , $T_j=25^\circ\text{C}$	—	5	70	mV
Load regulation	REG_{L}	$I_O=5$ to 500mA , $T_j=25^\circ\text{C}$	—	30	300	mV
		$I_O=5$ to 350mA , $T_j=25^\circ\text{C}$	—	10	150	mV
Bias current	I_{Bias}	$T_j=25^\circ\text{C}$	—	2	4	mA
Input bias current fluctuation	$\Delta I_{\text{bias (IN)}}$	$V_I=-27$ to -38V , $T_j=25^\circ\text{C}$	—	—	0.8	mA
Load bias current fluctuation	$\Delta I_{\text{bias (L)}}$	$I_O=5$ to 350mA , $T_j=25^\circ\text{C}$	—	—	0.4	mA
Output noise voltage	V_{no}	$f=10\text{Hz}$ to 100kHz , $T_a=25^\circ\text{C}$	—	600	—	μV
Ripple rejection ratio	RR	$V_I=-28$ to -38V , $I_O=100\text{mA}$, $f=120\text{Hz}$, $T_a=25^\circ\text{C}$	54	—	—	dB
Minimum input/output voltage difference	$V_{\text{DIF (min.)}}$	$T_j=25^\circ\text{C}$	—	1.1	—	V
Output short circuit current	$I_{\text{O (Short)}}$	$V_I=-35\text{V}$, $T_j=25^\circ\text{C}$	—	50	—	mA
Peak output current	$I_{\text{O (peak)}}$	$T_j=25^\circ\text{C}$	—	1000	—	mA
Output voltage temperature coefficient	$\Delta V_O/T_a$	$I_O=5\text{mA}$, $T_j=0$ to 125°C	—	-1	—	$\text{mV}/^\circ\text{C}$

Note 1) The specified condition $T_j=25^\circ\text{C}$ means that the test should be carried out with the test time so short (within 10ms) that the drift in characteristic value due to the rise in chip junction temperature can be ignored.

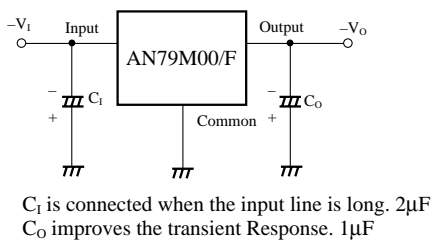
Note 2) When not specified, $V_I=-33\text{V}$, $I_O=350\text{mA}$, $C_I=2\mu\text{F}$, $C_O=1\mu\text{F}$ and $T_j=0$ to 125°C

* AN79M24 : 15W, AN79M24F : 10.25W

■ Characteristic Curve



■ Basic Regulator Circuit



■ Application Circuit

